# FILM CAPACITORS



### What is measured

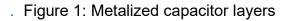
Delcom sensors can measure the sheet resistance, sheet conductance, and thickness of foil or metalized capacitors.

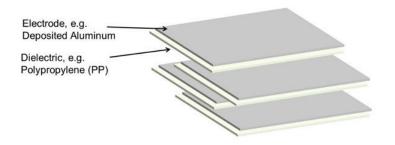
Delcom can measure all electrode material to include:

- Aluminum and aluminums alloy
- Zinc and zinc alloys

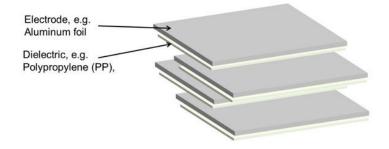
Finally, Delcom sensors implementation is compatible with all dielectric types to include:

- Polypropylene (PP), aka: Treofan
- Polyester, Polyethylene terephthalate (PET), aka: Hostaphan, Mylar
- Polyethylene naphthalate (PEN), aka: Kaladex
- Polyphenylene sulfide (PPS), aka: Torelina
- Polytetrafluoroethylene (PTFE), aka: Teflon
- Polystyrene (PS), aka: Styroflex
- Polycarbonate (PC), aka: Makrofol









# Why measure with Delcom

Manufacturers of foils and metalized films for capacitors target certain thicknesses of the conductive layer in order to optimize specific performance characteristics. The thickness of a metalized layer or a foil is directly proportional to the sheet conductance of that material and inversely related to the sheet resistance of that conductive layer. Therefore, the best way to measure the thickness -and therefore ensure the electrical performance specifications of a product – is to use a sheet resistance meter.

Delcom sensors are superior to optical systems which are useful, but ultimately a bad choice because they measure the distance between the top and the bottom of a coated layer or foil which may or may not correlate to the amount of metal present – that is to say they are unable to account for density and other factors.

Four point probes rely on contact measurements which means they cannot be used inline and often destroy the samples they are testing. Delcom sensors offer the following advantages over four point probes:

- Is non-destructive
- Reads through insulating layers
- Measures moving material
- Provides nearly instantaneous readings
- Provides real-time process inspection
- Not impeded by texture or patterns

## **Employment strategies**

Delcom eddy current sensors are ideal for the film capacitor industry. A Delcom sensor can be used in any of the following steps of the research through production continuum:

- During research and development to characterize conductive layers of different possible "recipes".
- During the production of the electrode conductive layer.
- Metal is rolled until it is of the desired thickness At each step, the Delcom sensor can be used inline to provide real time feedback on the thickness of the foil.
- Metal is evaporated and condenses on the dielectric layer or other material the Delcom sensor can be deployed in vacuum between deposition are rewind to provide the manufacturer with real-time feedback on the deposition thickness
- When characterizing the product before being slitted the "mother roll" into thin strips of the required width according to the size of the capacitors being manufactured.

• After slitting but before being wound into a capacitor. If this step is chosen, special attention must be paid to ensure the strip of material to be measured is of sufficient width.

All delcom sensors come in one of two varieties: vacuum-ready and not vacuum-ready. Vacuum ready sensors are devoid of anodized materials, nickel coated hardware, and insulators that out-gas. In general, silver colored sensors are vacuum-ready while black anodyzed sensors are not.

For in situ roll to roll process, the best placement for the Delcom sensor is inside the chamber just after the coating of the conductive material.

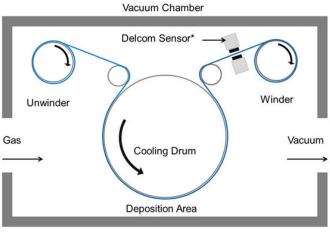


Figure 3: Delcom sensor placement in situ

\*This is illustrative, there should be an idle roller between the sensor and the winder

# Cross-web & downstream monitoring

In general, Delcom sensor deployment strategies can include one or more of the following deployment tactics.

Deployment	Image	Advantages
Strategy		
Single sensor single spot		<ul> <li>Most cost-effective option on the market</li> <li>One single fixed-point</li> <li>Achieve instantaneous process feedback</li> </ul>

Two sensors monitoring cross-web		• Monitor cross-web uniformity
Two sensors monitoring downstream	20J3 Vacuum-Ready On-line Sensors	• Monitor downstream consistency
Mutli- Channel monitoring cross-web	3 Sensor Positions	<ul> <li>Monitor cross-web uniformity</li> <li>Movable sensor positions</li> <li>Add sensor positions at a later time</li> </ul>
Measure layers prior to lamination	Laminator	• Know sheet resistance of individual layers in laminated stack

# **Recommended sensors**

Delcom recommends the following sensors based on the user's material, stage of development, and application.

Use case	Image	Recommended Sensor	Use case
http:	//www.delcom.com/   715	5-262-4466   <u>delcom@</u>	

Benchtop	RD200	<ul> <li>For material up to 12 mm thick</li> <li>For materials up to 200 mm x 200 mm</li> </ul>
Benchtop	RM400	<ul> <li>Automatic mapping</li> <li>For material up to 400 mm x 400 mm</li> </ul>
Inline	20J3	<ul> <li>Most cost-effective inline solution</li> <li>200 mm reach and 3 mm gap</li> </ul>
Inline	OEM	<ul> <li>Variable position, gap, and spot size</li> <li>Customer decides where and how to mount</li> </ul>
Inline	Inline	<ul> <li>Monitor cross-web uniformity</li> <li>Variable position, gap, and spot size</li> <li>Add channels anytime</li> </ul>

### **Recommended sensor range**

Delcom sensors measure sheet resistance. Delcom makes sensors in four ranges – each range able to measure a different range of sheet resistances. When considering which sensor is right for a particular application, the right range of instrument must be selected based on the target sheet resistance of the material.

Figure 4. Delcont s sensor ranges.			
Range Name	Min Sheet Resistance in ohms/square	Max Sheet Resistance in ohms/square	
x10	5	100000	
x1	0.5	10000	
÷10	0.05	1000	
÷100	0.005	100	

#### Figure 4: Delcom's sensor ranges:

For wound thin film (or foil) capacitors target sheet resistance of the electrode layer can range from 0.01 – 1000 ohms per square with typical metallization thicknesses range from approximately 1-4 ohms per square. Given these materials and these target sheet resistance values, the thickness of the deposited material can be calculated.

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MATERIAL	ρ (RESISTIVITY) IN OHM-CM	Target sheet resistance in ohms/square	Target thickness in micrometers
Aluminum	2.65 × 10-6	1	0.0265
		4	0.0066
Zinc	5.9 × 10-6	1	0.0590
		4	0.0148

Figure 5	Target thickness	of denosited	l metalized films
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According to this chart, the appropriate sensor range for these products is a x10 instrument (also called an 8N).